


<b>Search Notes</b>  	<b>Application/Control No.</b>  10529765	<b>Applicant(s)/Patent Under Reexamination</b>  MEIER ET AL.
	<b>Examiner</b>  MINH-CHAU T PHAM	<b>Art Unit</b>  1797

SEARCHED			
Class	Subclass	Date	Examiner
55	385.1, 385.6, 410.1, 418.1, 467.1, 351.1	12/7/09	MCP
34	77, 79	12/7/09	MCP
228	42, 37, 222, 223	12/7/09	MCP
75	336, 338	12/7/09	MCP
228	46, 200, 219	12/7/09	MCP
210	806, 690, 692, 693	12/7/09	MCP
95	277, 288, 270-274, 290, 296, 297, 299, 322, 325, 327, 328	12/7/09	MCP
96	377, 414, 420, 421	12/7/09	MCP
261	112.1, 104	12/7/09	MCP

SEARCH NOTES		
Search Notes	Date	Examiner
East search for Classes 55, 34, 75, 95, 96, 210, 228 and 261	12/7/09	MCP
Text search	12/7/09	MCP
Inventor search	12/7/09	MCP
Consulted with Primary Examiner Matthew Savage on Class 261	12/7/09	MCP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
55	385.1, 385.6, 410.1, 418.1, 467.1, 351.1	12/7/09	MCP
34	77, 79	12/7/09	MCP
228	37, 42, 222, 223, 46, 200, 219	12/7/09	MCP
75	336, 338	12/7/09	MCP
210	806, 690, 692, 693	12/7/09	MCP
95	274, 288, 270-273, 277, 290, 296, 297, 299, 322, 325, 327, 328	12/7/09	MCP
96	377, 414, 420, 421, 210, 211, 216, 217	12/7/09	MCP
261	112.1, 104	12/7/09	MCP

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